



Docket No.: 50090-443

PATENT

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Application of	:	Customer Number: 20277
Kazunobu MIKI	:	Confirmation Number: 5044
Serial No.: 09/973,049	:	Group Art Unit: 2829
Filed: October 10, 2001	:	Allowed: October 21, 2003
	:	Examiner: J. M. Hollington
For: SEMICONDUCTOR ELEMENT TEST APPARATUS, AND METHOD OF TESTING SEMICONDUCTOR ELEMENT USING THE APPARATUS		

**LETTER SUBMITTING FORMAL DRAWINGS**

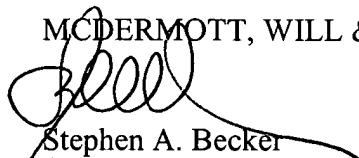
Mail Stop Issue Fee  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In response to the Notice of Allowability dated October 21, 2003, submitted herewith are nine (09) sheets of Formal Drawings in connection with the above referenced application.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

  
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**Date: January 9, 2004**